

Search Notes

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Examiner

Nguyen N. Hanh

Applicant(s)/Patent under
Reexamination

NICKEL-JETTER ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
310	156.01- 156.84	7/27/2005	HN
310	67R	7/27/2005	HN
310	68D	7/27/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR